

FMOS014N02E

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FMOS014N02E

1.0A, 20V N-Channel Enhancement Mode MOSFET

Features

- $V_{DS} = 20V, I_D = 1.0A.$
- $R_{DS(ON)} \leq 230m\Omega @V_{GS}=4.5V, I_D=550mA.$
- $R_{DS(ON)} \leq 305m\Omega @V_{GS}=2.5V, I_D=450mA.$
- $R_{DS(ON)} \leq 455m\Omega @V_{GS}=1.8V, I_D=350mA.$
- Fast switching speed.
- Reliable and rugged.
- ESD Protection.
- RoHS compliant & Halogen - Free.
- Suffix "-H" indicates Halogen-free part, ex.FMOS014N02E-H.

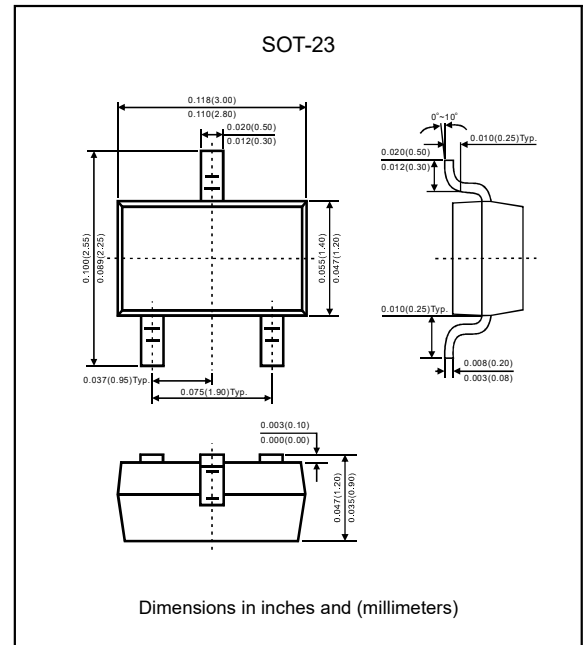
Applications

- DC / DC Converters.
- Small signal switch.
- Load switch.

Mechanical data

- Epoxy:UL94-V0 rated flame retardant
- Case : Molded plastic, SOT-23
- Terminals : Solder plated, solderable per MIL-STD-750, Method 2026
- Mounting Position : Any
- Weight : Approximated 0.008 gram

Package outline



Maximum ratings (T_A=25°C unless otherwise noted)

Parameter	Symbol	Ratings	Unit
Drain-source voltage	V_{DS}	20	V
Gate-source voltage	V_{GS}	±8	V
Continuous drain current (T _A =25°C)	I_D	1.0	A
(T _A =70°C)		0.8	
Diode continuous forward current	I_S	0.4	A
Pulse drain current tested (Note 1)	I_{DM}	2.5	A
Power dissipation (T _A =25°C)	P_D	360	mW
Thermal resistance form junction to ambient (Note 2)	$R_{\theta JA}$	350	°C/W
Operating Junction temperature range	T_J	+150	°C
Storage temperature range	T_{STG}	-55 to +150	°C

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Electrical characteristics (At $T_j=25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Off characteristics						
Drain-source breakdown voltage	BV_{DSS}	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	20			V
Drain-source leakage current	I_{DSS}	$V_{DS}=16\text{V}, V_{GS}=0\text{V}$			1	μA
Gate-source leakage current	I_{GSS}	$V_{GS}=\pm 8\text{V}, V_{DS}=0\text{V}$			± 10	μA
On characteristics						
Gate threshold voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	0.5		1.0	V
Forward transconductance	g_{FS}	$V_{DS}=5\text{V}, I_D=550\text{mA}$		1.7		S
Static drain-source on-resistance (Note 3)	$R_{DS(ON)}$	$V_{GS}=4.5\text{V}, I_D=550\text{mA}$		190	230	m Ω
		$V_{GS}=2.5\text{V}, I_D=450\text{mA}$		234	305	
		$V_{GS}=1.8\text{V}, I_D=350\text{mA}$		303	455	
Dynamic Parameters (Note 4)						
Gate resistance	R_G	$V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1.0\text{MHz}$		198		Ω
Input capacitance	C_{iss}	$V_{GS}=0\text{V}, V_{DS}=10\text{V}, f=1.0\text{MHz}$		43		pF
Output capacitance	C_{oss}			9		
Reverse transfer capacitance	C_{rss}			6		
Switching parameters						
Total gate charge	Q_g	$V_{GS}=4.5\text{V}, V_{DS}=10\text{V}, I_D=1\text{A}$		2		nC
Gate to source charge	Q_{gs}			0.3		
Gate to Drain charge	Q_{gd}			0.3		
Turn-on delay time	$t_{d(on)}$	$V_{DS}=10\text{V}, V_{GS}=4.5\text{V}, I_D=2\text{A}, R_G=6\Omega$		1.2		ns
Rise time	t_r			25		
Turn-off delay time	$t_{d(off)}$			14		
Fall time	t_f			15		
Source-drain diode ratings and characteristics						
Reverse recovery time	t_{rr}	$I_F=1\text{A}, V_R=0\text{V}, dI_F/dt=100\text{A}/\mu\text{s}$		9.2		ns
Reverse recovery charge	Q_{rr}			0.8		nC
Drain - source diode forward voltage (Note 3)	V_{SD}	$V_{GS}=0\text{V}, I_{SD}=1\text{mA}$		0.9	1.1	V

- Note : 1. Max. Current is limited by junction temperature.
 2. Surface mounted on 1 in² FR4 board with 1oz.
 3. Pulse test (Pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$).
 4. Guaranteed by design, not subject to production testing.

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Rating and characteristic curves

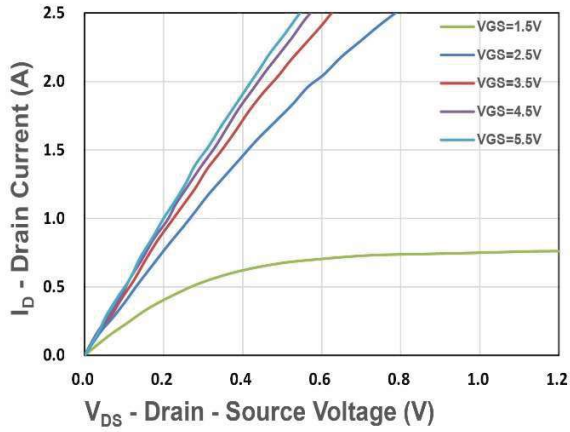


Figure 1. Output Characteristics

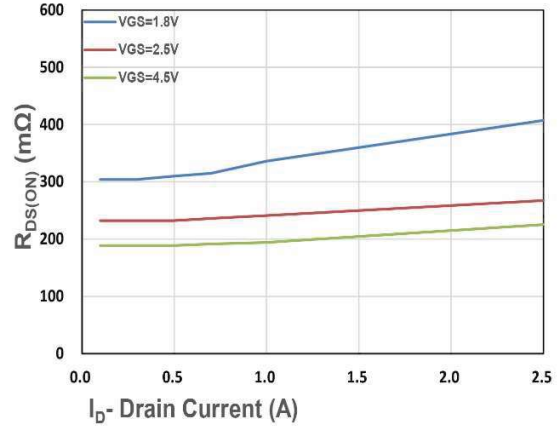


Figure 2. On-Resistance vs. ID

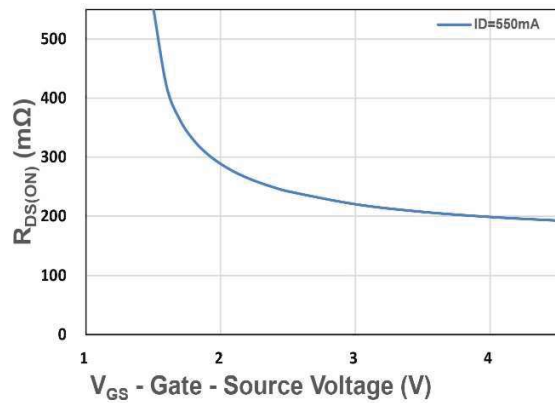


Figure 3. On-Resistance vs. VGS

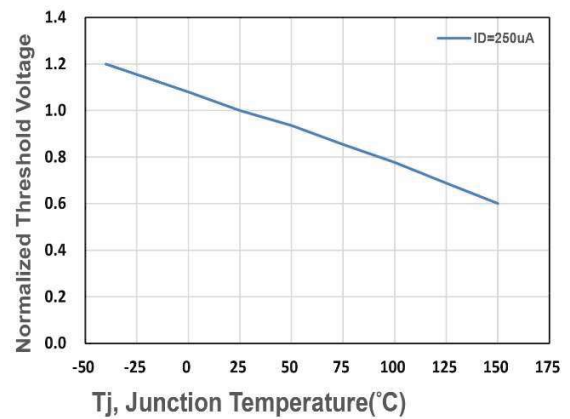


Figure 4. Gate Threshold Voltage

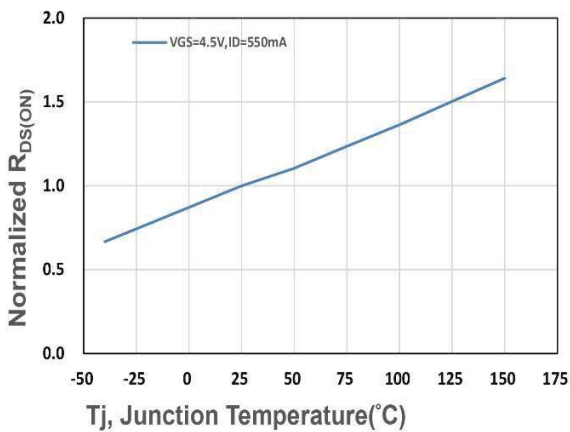


Figure 5. Drain-Source On Resistance

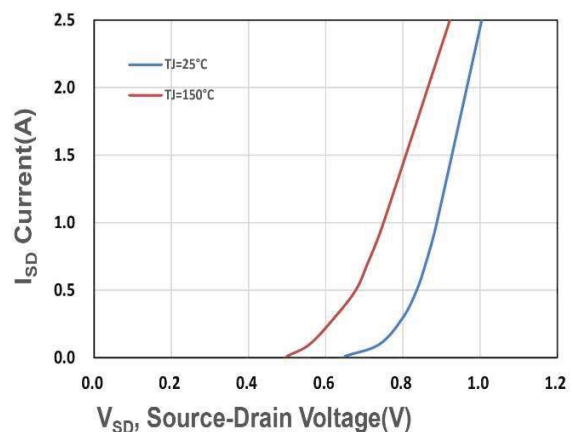
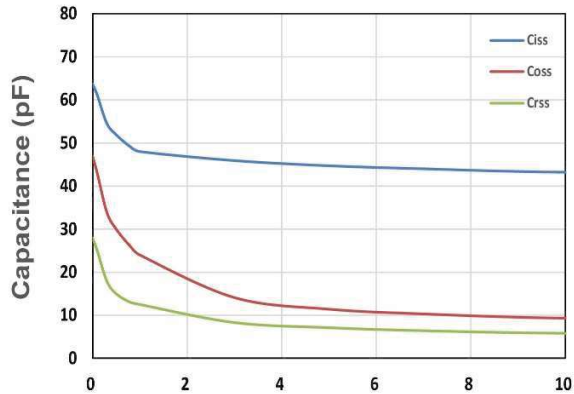


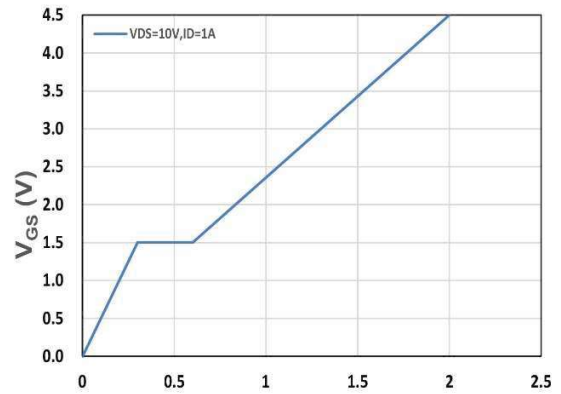
Figure 6. Source-Drain Diode Forward

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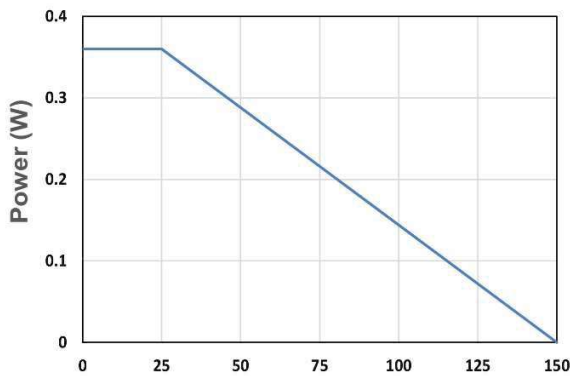
Rating and characteristic curves



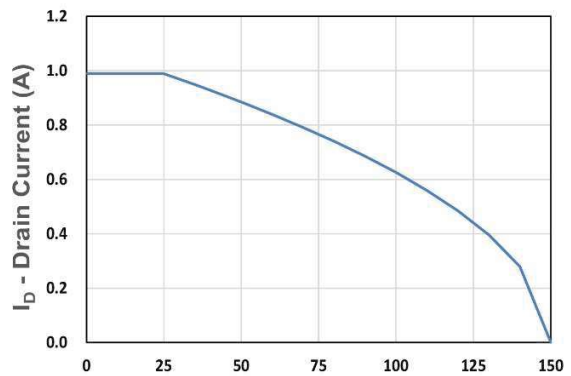
V_{DS} - Drain - Source Voltage (V)
Figure 7. Capacitance



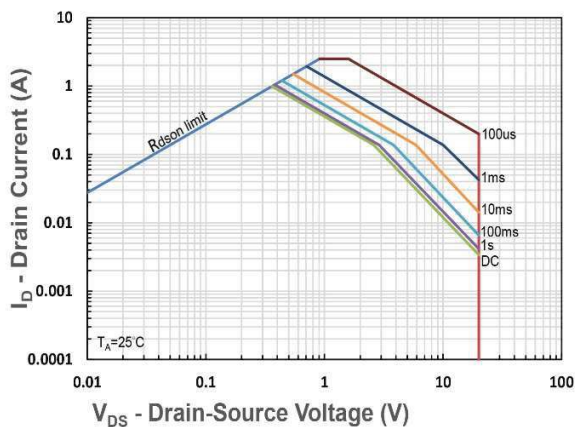
V_{GS} (V)
Qg, Total Gate Charge (nC)
Figure 8. Gate Charge Characteristics



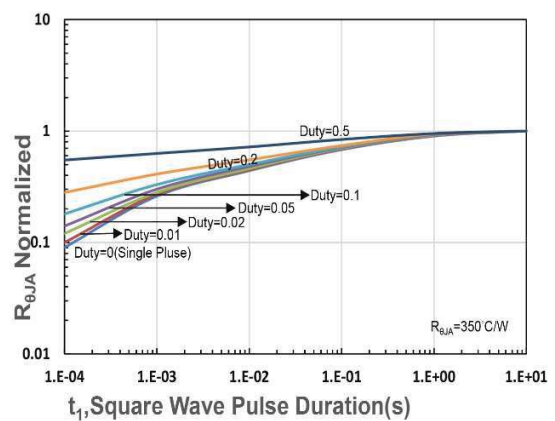
T_A - Ambient Temperature (°C)
Figure 9. Power Dissipation



T_A - Ambient Temperature (°C)
Figure 10. Drain Current



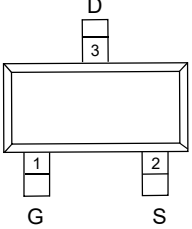
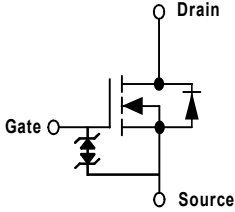
V_{DS} - Drain-Source Voltage (V)
Figure 11. Safe Operating Area



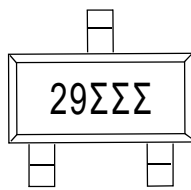
$R_{\theta JA}$ Transient Thermal Impedance
Figure 12. $R_{\theta JA}$ Transient Thermal Impedance

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Pinning information

Pin	Simplified outline	Symbol
Pin1 Gate Pin2 Source Pin3 Drain		

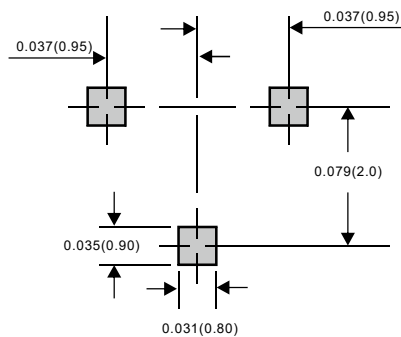
Marking



Σ Σ Σ : Date Code

Suggested solder pad layout

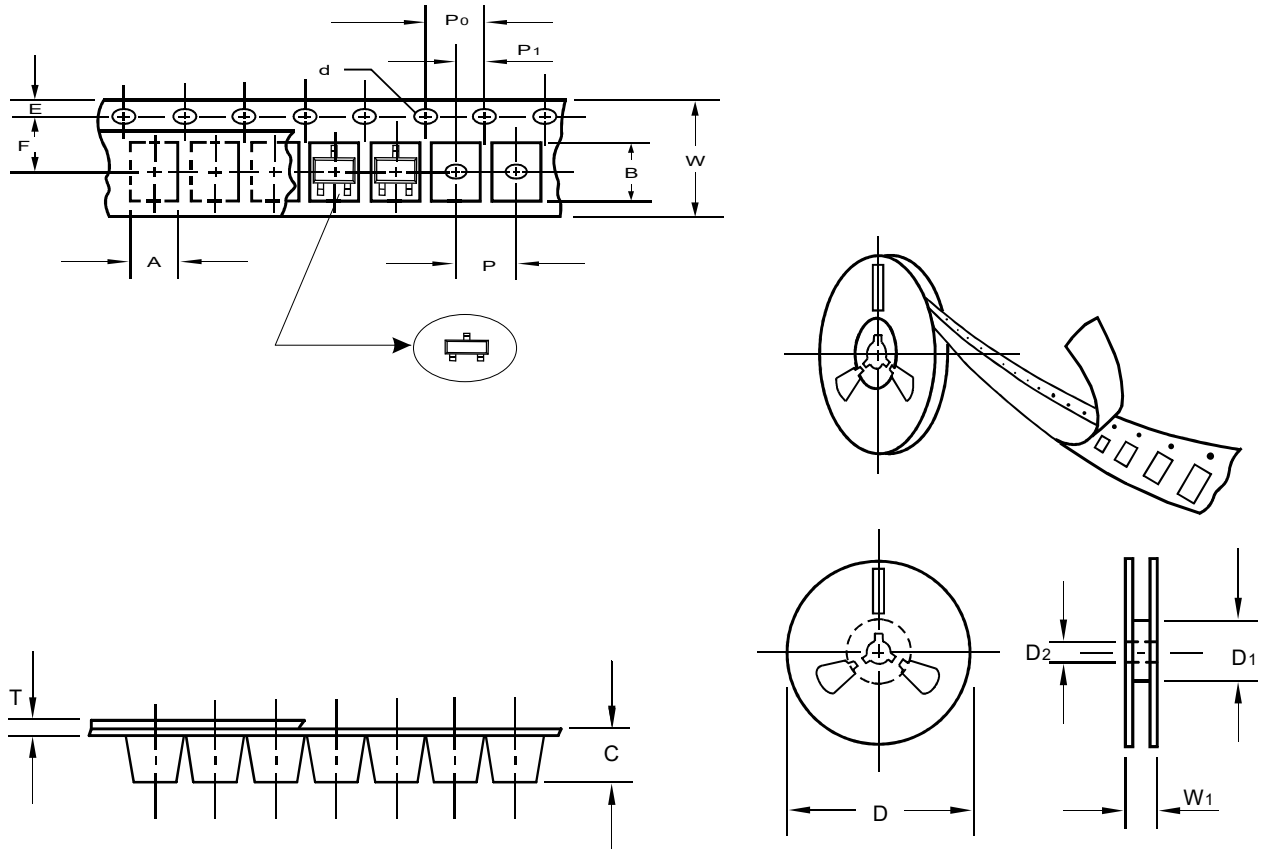
SOT-23



Dimensions in inches and (millimeters)

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Packing information



unit:mm

Item	Symbol	Tolerance	SOT-23
Carrier width	A	0.1	3.15
Carrier length	B	0.1	2.77
Carrier depth	C	0.1	1.22
Sprocket hole	d	0.1	1.50
13" Reel outside diameter	D	2.0	-
13" Reel inner diameter	D1	min	-
7" Reel outside diameter	D	2.0	178.00
7" Reel inner diameter	D1	min	54.40
Feed hole diameter	D2	0.5	13.00
Sprocket hole position	E	0.1	1.75
Punch hole position	F	0.1	3.50
Punch hole pitch	P	0.1	4.00
Sprocket hole pitch	P0	0.1	4.00
Embossment center	P1	0.1	2.00
Overall tape thickness	T	0.1	0.23
Tape width	W	0.3	8.00
Reel width	W1	1.0	11.40

Note: Devices are packed in accordance with EIA standard RS-481-A and specifications listed above.

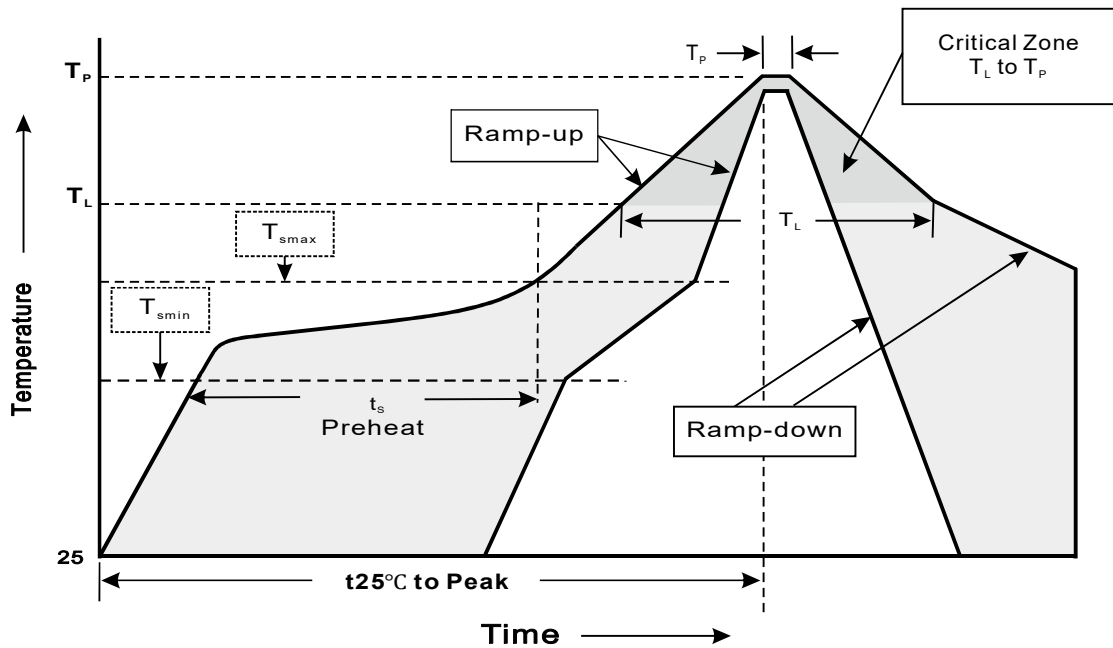
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Reel packing

PACKAGE	REEL SIZE	REEL (pcs)	COMPONENT SPACING (m/m)	BOX (pcs)	INNER BOX (m/m)	REEL DIA, (m/m)	CARTON SIZE (m/m)	CARTON (pcs)	APPROX. GROSS WEIGHT (kg)
SOT-23	7"	3,000	4.0	30,000	183*123*183	178	382*257*387	240,000	11.6

Suggested thermal profiles for soldering processes

- Storage environment: Temperature=5°C~40°C Humidity=55%±25%
- Reflow soldering of surface-mount devices



3.Reflow soldering

Profile feature	Soldering Condition
Average ramp-up rate (T_L to T_p)	< 3°C/sec
Preheat -Temperature Min (T_{smin}) -Temperature Max (T_{smax}) -Time (min to max) (t_s)	150°C 200°C 60 ~ 120sec
T_{smax} to T_L -Ramp-up rate	< 3°C/sec
Time maintained above: -Temperature (T_L) -Time(T_L)	217°C 60 ~ 260 sec
Peak Temperature(T_p)	255°C -0/+5°C
Time within 5°C of actual peak Temperature(T_p)	10 ~ 30sec
Ramp-down rate	< 6°C/sec
Time 25°C to peak temperature	< 6 minutes